

Notice of References Cited	Application/Control No. 10/662,394	Applicant(s)/Patent Under Reexamination AKIYAMA ET AL.	
	Examiner Danny Wai Lun Leung	Art Unit 2613	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,512,612 B1	01-2003	Fatehi et al.	398/49
*	B	US-6,154,273 A	11-2000	Suzuki, Yasuo	356/73.1
*	C	US-6,885,820 B2	04-2005	Eder et al.	398/26
*	D	US-6,859,268 B2	02-2005	Chou et al.	356/73.1
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Morkel, P.R., "PMD-induced BER penalties in optically-amplified IM/DD lightwave systems", IEEE Electronics Letters, 12 May 1994, Vol 30, Iss 10, page 806-807
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.